

INTERNATIONAL STANDARD

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**Organic light emitting diode (OLED) displays –
Part 6-2: Measuring methods of visual quality and ambient performance**

**Afficheurs à diodes électroluminescentes organiques (OLED) –
Partie 6-2: Méthodes de mesure de la qualité visuelle et des caractéristiques de
fonctionnement sous conditions ambiantes**



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INTERNATIONAL
ELECTROTECHNICAL
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PRICE CODE
CODE PRIX



ICS 31.260

ISBN 978-2-88912-893-8

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ORGANIC LIGHT EMITTING DIODE (OLED) DISPLAYS –

Part 6-2: Measuring methods of visual quality and ambient performance

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The text of this standard is based on the following documents:

FDIS	Report on voting
110/338/FDIS	110/353/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

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